

**Notice of References Cited**

Application/Control No.

10/525,758

Applicant(s)/Patent Under  
Reexamination  
HOSHINO ET AL.

Examiner

Aaron S. Austin

Art Unit

1775

Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-3,860,432	01-1975	Higuchi et al.	501/153
	B	US-			
	C	US-			
	D	US-			
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	JP 2001213666 A	08-2001	Japan	IZUTSU et al.	
	O	JP-B-3139962	11-1997	Japan	Goto Tetsuro et al.	
	P	JP 2002037676 A	02-2002	Japan	HAYASHI, KOJI	
	Q	JP 2001130084 A	05-2001	Japan	MURAKAMI, MASAKATSU	
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.